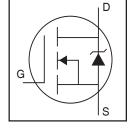


# AUIRLS3034

## HEXFET® Power MOSFET

#### **Features**

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>	40V
R <sub>DS(on)</sub> typ.	<b>1.4m</b> $\Omega$
max.	1.7m $\Omega$
I <sub>D (Silicon Limited)</sub>	343A①
I <sub>D (Package Limited)</sub>	195A



G	D	S
Gate	Drain	Source

## Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	343①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	243 ①	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	195	_ A
I <sub>DM</sub>	Pulsed Drain Current ②	1372	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	375	W
	Linear Derating Factor	2.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	±20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ③	255	mJ
I <sub>AR</sub>	Avalanche Current ②	0 5:- 44 45 00- 005	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ©	See Fig. 14, 15, 22a, 22b,	mJ
dv/dt	Peak Diode Recovery ®	4.6	V/ns
T <sub>J</sub>	Operating Junction and	FF 42 : 47F	
T <sub>STG</sub>	Storage Temperature Range	-55 to + 175	_ °C
	Soldering Temperature, for 10 seconds	200	
	(1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lbf·in (1.1N·m)	

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case 9 ®		0.4	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ®		40	C/VV

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/

## Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.04		V/°C	Reference to 25°C, $I_D = 5mA$ ②
В	Static Drain-to-Source On-Resistance		1.4	1.7	m()	$V_{GS} = 10V, I_D = 195A $ ⑤
R <sub>DS(on)</sub>	Static Drain-to-Source Ori-Resistance		1.6	2.0	ms2	$V_{GS} = 4.5V, I_D = 172A $ §
V <sub>GS(th)</sub>	Gate Threshold Voltage	1.0		2.5	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Transconductance	286			S	$V_{DS} = 10V, I_{D} = 195A$
R <sub>G(int)</sub>	Internal Gate Resistance		2.1		Ω	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 40V, V_{GS} = 0V$ $V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
				250	μA	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nΛ	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	verse Leakage		-100	nA	$V_{GS} = -20V$

### Dynamic Electrical Characteristics @ T<sub>.I</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$Q_g$	Total Gate Charge		108	162		I <sub>D</sub> = 185A
$Q_{gs}$	Gate-to-Source Charge		29			$V_{DS} = 20V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		54		nC	V <sub>GS</sub> = 4.5V ⑤
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		54			$I_D = 185A, V_{DS} = 0V, V_{GS} = 4.5V$
t <sub>d(on)</sub>	Turn-On Delay Time		65			$V_{DD} = 26V$
t <sub>r</sub>	Rise Time		827		]	I <sub>D</sub> = 195A
t <sub>d(off)</sub>	Turn-Off Delay Time		97		ns	$R_G = 2.1\Omega$
t <sub>f</sub>	Fall Time		355			V <sub>GS</sub> = 4.5V ⑤
C <sub>iss</sub>	Input Capacitance		10315			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		1980			$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		935		рF	f = 1.0MHz
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		2378			$V_{GS} = 0V$ , $V_{DS} = 0V$ to 32V $\bigcirc$
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related) ©		2986			V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 32V ©

#### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			343 <sup>①</sup>		MOSFET symbol
	(Body Diode)			343⊕	Α	showing the
I <sub>SM</sub>	Pulsed Source Current			1372	A	integral reverse
	(Body Diode) ②			13/2		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	٧	$T_J = 25$ °C, $I_S = 195$ A, $V_{GS} = 0$ V $\$$
t <sub>rr</sub>	Reverse Recovery Time		39			$T_J = 25^{\circ}C$ $V_R = 34V$ ,
			41			$T_J = 125^{\circ}C$ $I_F = 195A$
Q <sub>rr</sub>	Reverse Recovery Charge		39			$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s ©
			46		IIC	$T_J = 125^{\circ}C$
I <sub>RRM</sub>	Reverse Recovery Current		1.7		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrinsi	ic turn-	on time	is neg	ligible (turn-on is dominated by LS+LD)

#### Notes:

- ① Calcuted continuous current based on maximum allowable junction temperature Bond wire current limit is 195A. Note that current limitation arising from heating of the device leds may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $\textcircled{1} \label{eq:loss_state} I_{SD} \leq 195 A, \ di/dt \leq 841 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_{J} \leq 175^{\circ}C.$

- $\ \ \, \ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \$   $\$   $\ \$   $\ \$   $\$   $\ \$   $\ \$   $\$   $\$   $\$   $\$   $\ \$   $\$
- $\ \ \,$  C  $_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as C  $_{oss}$  while V  $_{DS}$  is rising from 0 to 80% V  $_{DSS}.$
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to applocation note # AN-994.
- $\ \mathfrak{D}\ \mathsf{R}_\theta$  is measured at  $\mathsf{T}_\mathsf{J}$  approximately 90°C.
- $\ \, \mathfrak{D} \, \, \, \mathsf{R}_{\theta \mathsf{JC}} \, \mathsf{value} \, \, \mathsf{shown} \, \, \mathsf{is} \, \, \mathsf{at} \, \, \mathsf{time} \, \, \mathsf{zero}.$

## **Qualification Information**<sup>†</sup>

			Automotive (per AEC-Q101) ††					
Qualification Level		qualification.	Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification leve is granted by extension of the higher Automotive level.					
Moisture Sensitivity Level		D <sup>2</sup> Pak	D <sup>2</sup> Pak MSL1					
Machine Model			Class M4 (+/- 800V) <sup>†††</sup>					
			AEC-Q101-002					
	Human Body Model		Class H3A (+/- 6000V) <sup>†††</sup>					
ESD			AEC-Q101-001					
	Charged Device Model		Class C5 (+/- 2000V) <sup>†††</sup>					
			AEC-Q101-005					
RoHS Compliant	1		Yes					

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

<sup>††</sup> Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

<sup>†††</sup> Highest passing voltage.

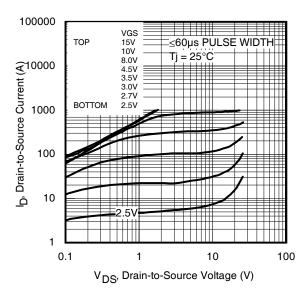


Fig 1. Typical Output Characteristics

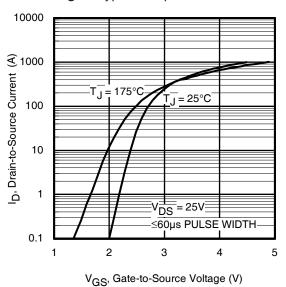


Fig 3. Typical Transfer Characteristics

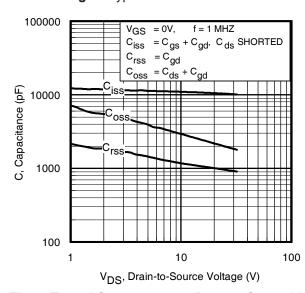


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

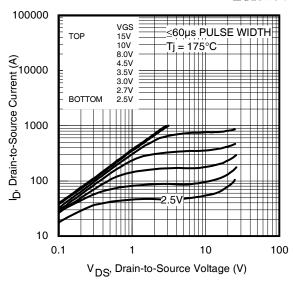


Fig 2. Typical Output Characteristics

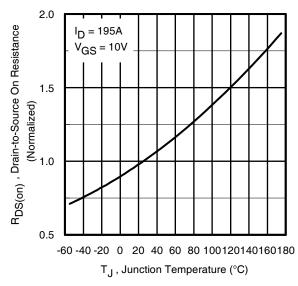


Fig 4. Normalized On-Resistance vs. Temperature

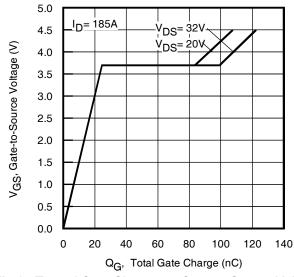


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

4

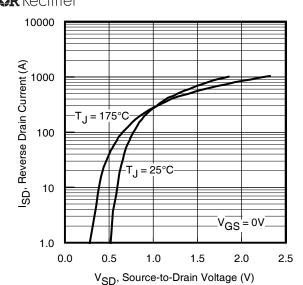
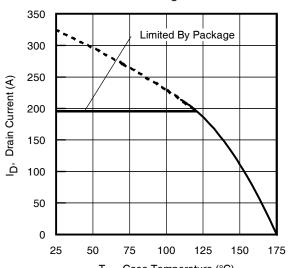
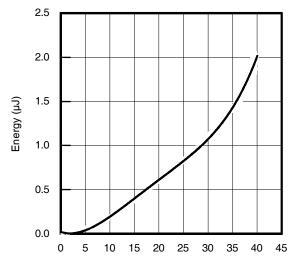


Fig 7. Typical Source-Drain Diode Forward Voltage



T<sub>C</sub> , Case Temperature (°C) **Fig 9.** Maximum Drain Current vs.

Case Temperature



 $\label{eq:VDS} V_{DS,} \mbox{ Drain-to-Source Voltage (V)} \\ \mbox{ Fig 11. Typical $C_{OSS}$ Stored Energy}$ 

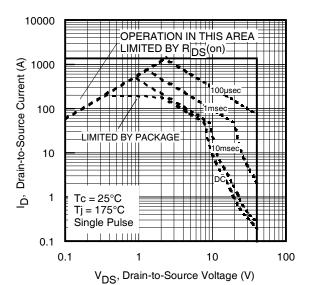


Fig 8. Maximum Safe Operating Area

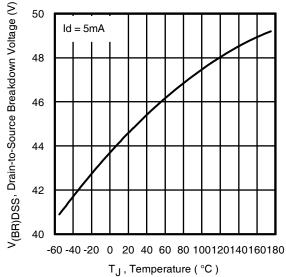


Fig 10. Drain-to-Source Breakdown Voltage

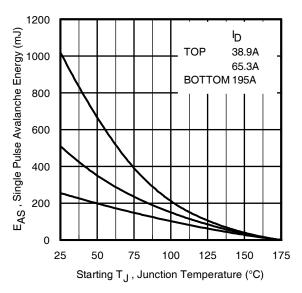


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

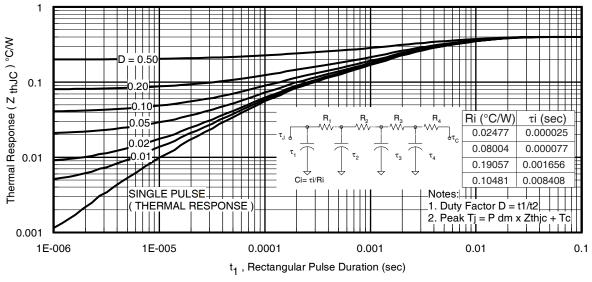


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

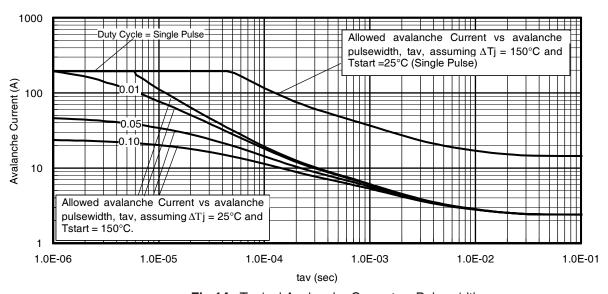


Fig 14. Typical Avalanche Current vs. Pulsewidth

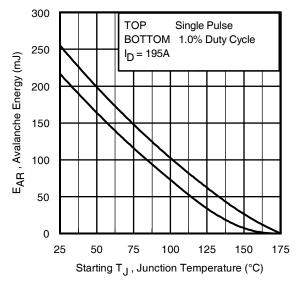


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long  $asT_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

t<sub>av =</sub> Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ ( } 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \triangle \text{T/ } Z_{thJC} \\ I_{av} &= 2\triangle \text{T/ [ } 1.3 \cdot \text{BV} \cdot Z_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

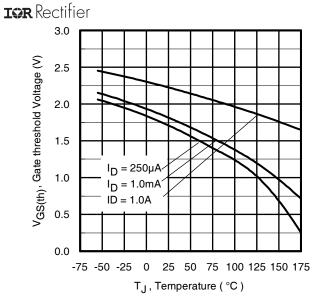


Fig 16. Threshold Voltage vs. Temperature

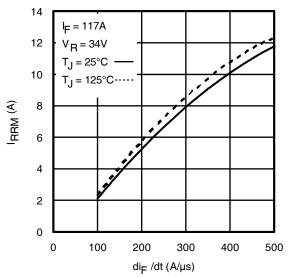


Fig. 18 - Typical Recovery Current vs. dif/dt

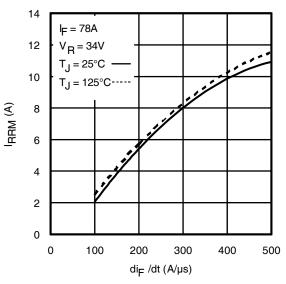


Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt

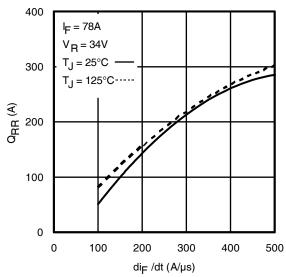


Fig. 19 - Typical Stored Charge vs. dif/dt

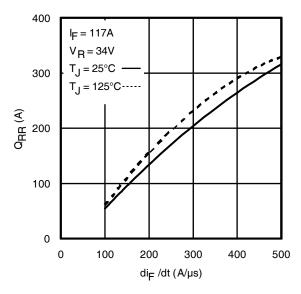


Fig. 20 - Typical Stored Charge vs. dif/dt

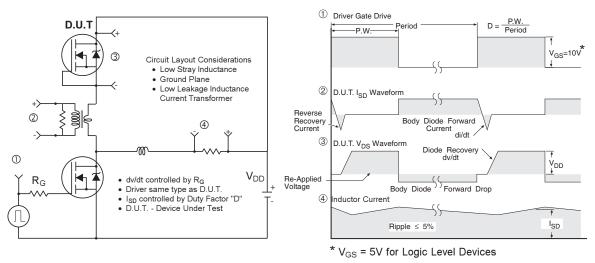


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

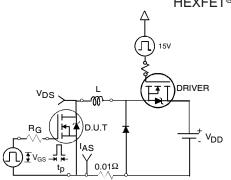


Fig 22a. Unclamped Inductive Test Circuit

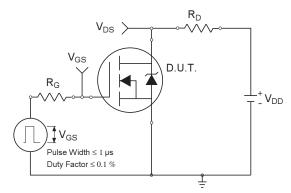


Fig 23a. Switching Time Test Circuit

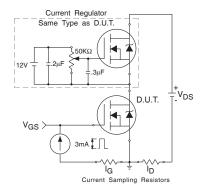


Fig 24a. Gate Charge Test Circuit

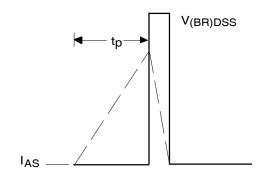


Fig 22b. Unclamped Inductive Waveforms

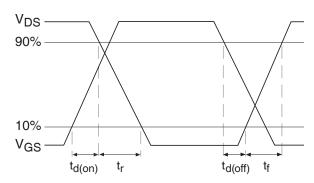


Fig 23b. Switching Time Waveforms

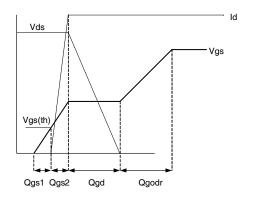
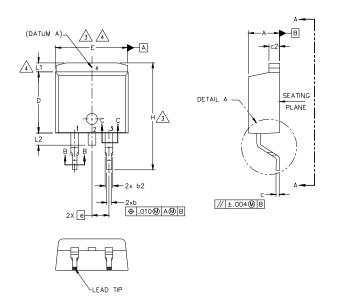


Fig 24b. Gate Charge Waveform

# $D^2Pak\ Package\ Outline\ (Dimensions\ are\ shown\ in\ millimeters\ (inches))$

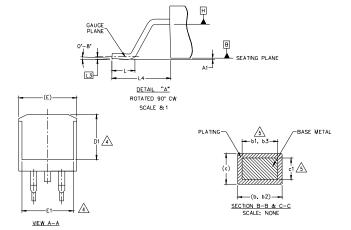


S Y M		N			
B O	MILLIM	ETERS	INC	O T E S	
L	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
ь	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
Ε	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	-	1.65	-	.066	4
L2	1.27	1.78	-	.070	
L3	0.25	BSC	.010	BSC	
L4	4.78	5.28	.188	.208	

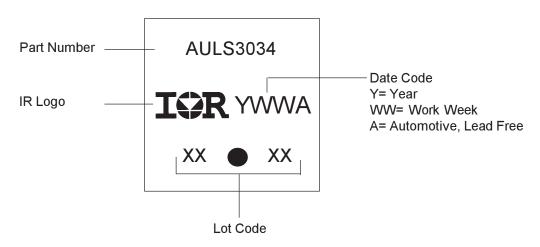
S Y		DIMEN	SIONS		N	LEAD ASSIGNMENTS				
M B	MILLIM	ETERS	INC	HES	Q T	DIODES				
) L	MIN.	MAX.	MIN.	MAX.	E 1.— ANODE (TWO DIE) / OPEN (ON S 2, 4.— CATHODE	1.— ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.— CATHODE				
4	4.06	4.83	.160	.190		3 ANODE				
۸1	0.00	0.254	.000	.010		HEXFET IGBTs, CoPACK				
5	0.51	0.99	.020	.039		HEXFET IGBTs, CoPACK				
1	0.51	0.89	.020	.035	5	1 GATE 1 GATE				
2	1.14	1.78	.045	.070		2, 4 DRAIN 2, 4 COLLECTOR 3 SOURCE 3 EMITTER				
3	1.14	1.73	.045	.068	5	5. EMITTER				
С	0.38	0.74	.015	.029						
:1	0.38	0.58	.015	.023	5					
2	1.14	1.65	.045	.065						
)	8.38	9.65	.330	.380	3					
)1	6.86	-	.270		4					
Ξ	9.65	10.67	.380	.420	3,4					
1	6.22	-	.245		4					
е	2.54	BSC	.100	BSC	1					
+	14.61	15.88	.575	.625	]					
	1.78	2.79	.070	.110						
.1	-	1.65	-	.066	4					
2	1.27	1.78	-	.070						
.3	0.25	BSC	.010	BSC						

#### NOTES:

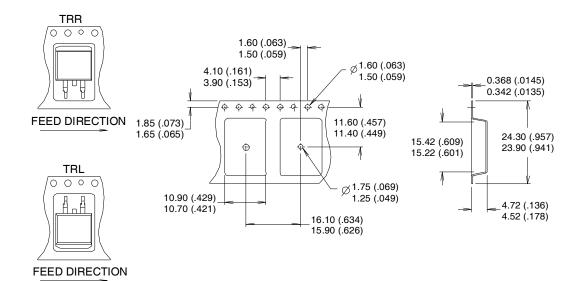
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

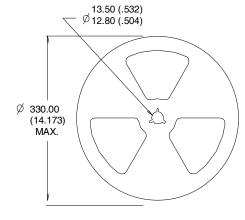


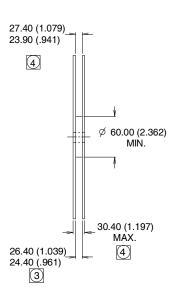
## D<sup>2</sup>Pak Part Marking Information



## D<sup>2</sup>Pak Tape & Reel Information







## NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

# **Ordering Information**

Base part number	Package Type	Standard Pack	Complete Part Number	
		Form	Quantity	
AUIRLS3034	D2Pak	Tube	50	AUIRLS3034
		Tape and Reel Left	800	AUIRLS3034TRL
		Tape and Reel Right	800	AUIRLS3034TRR

#### IMPORTANT NOTICE

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